

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 09/851,065 | Applicant(s)/Patent Under Reexamination CRUANES ET AL. | |
| | Examiner Majid A Banankhah | Art Unit 2127 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-6,665,684 | 12-2003 | Zait et al. | 707/102 |
| | B | US-5,878,409 | 03-1999 | Baru et al. | 707/2 |
| | C | US-5,687,369 | 11-1997 | Li, Shih-Gong | 707/203 |
| | D | US-6,510,428 | 01-2003 | Tsuchida et al. | 707/6 |
| | E | US-6,505,187 | 01-2003 | Shatdal, Ambuj | 707/2 |
| | F | US-6,169,989 | 01-2001 | Eichstaedt et al. | 707/100 |
| | G | US-6,282,570 | 08-2001 | Leung et al. | 709/224 |
| | H | US-6,564,221 | 05-2003 | Shatdal, Ambuj | 707/102 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.